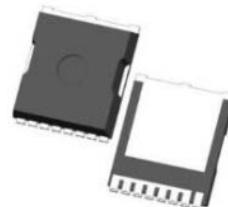


100V N-Channel Power MOSFET

DESCRIPTION :

- High Speed Power Switching
- Low On-Resistance
- 100% UIS Tested, 100% R_g Tested
- RoHS compliant
- Halogen Free

V _{DS}	100V
I _{D_MAX}	351A
R _{DSON_MAX} @ V _{GS} =10V	1.7mΩ



TOLL

MAXIMUM RATINGS (at T_c = 25 °C, unless otherwise specified)

Characteristic	Condition	Symbol	Value	Unit
Drain-Source Voltage		V _{DS}	100	V
Gate-Source Voltage		V _{GS}	±20	V
Continuous Drain Current	T _c =25°C T _c =100°C	I _D	351 249	A
Pulse Drain Current ⁽¹⁾		I _{DM}	1406	A
Single Pulse Avalanche Energy ⁽²⁾		E _{AS}	1850	mJ
Single Pulse Avalanche Current	L=0.3mH	I _{AS}	71	A
Maximum Power Dissipation	T _c =25°C T _c =100°C	P _D	429 214	W
Junction & Storage Temperature Range		T _J , T _{STG}	-55~+175	°C

THERMAL CHARACTERISTICS

Characteristic	Condition	Symbol	Value	Unit
Thermal Resistance, Junction to Ambient		R _{θJA}	29	°C/W
Thermal Resistance, Junction to Case		R _{θJC}	0.35	°C/W

Notes:

1.This current is calculated on single pulse with 10us Single Pulse.

2. Defined by design, not subject to production test, EAS condition: T_J=25°C, V_{DD}=50V, V_{GS}=10V, L=1.0mH.

ELECTRICAL CHARACTERISTICS (at $T_J = 25^\circ\text{C}$, unless otherwise specified)

Characteristic	Symbol	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage $V_{GS} = 0\text{V}$, $ID = 250\mu\text{A}$	$V_{(BR)DSS}$	100			V
Zero Gate Voltage Drain Current $V_{DS} = 100\text{ V}$, $V_{GS} = 0\text{ V}$ $T_J=25^\circ\text{C}$ $V_{DS} = 100\text{ V}$, $V_{GS} = 0\text{ V}$ $T_J=125^\circ\text{C}$	I_{DSS}			1 100	μA
Gate-Source Leakage Current $V_{GS} = \pm 20\text{V}$, $V_{DS} = 0\text{V}$	I_{GSS}			± 100	nA
Gate-Source Threshold Voltage $V_{DS} = V_{GS}$, $ID = 250\mu\text{A}$	$V_{GS(\text{th})}$	2.0	3.0	4.0	V
Drain-Source On-State Resistance $V_{GS} = 10\text{V}$, $ID = 20\text{A}$	$R_{DS(\text{ON})}$			1.4	$\text{m}\Omega$
Forward Transconductance $V_{DS} = 5\text{V}$, $ID = 20\text{A}$	G_{fS}		67		S
Input capacitance $f=1\text{MHz}$, $V_{DS}=50\text{ V}$, $V_{GS}=0\text{ V}$	C_{iss}		9665		pF
Output capacitance $f=1\text{MHz}$, $V_{DS}=50\text{ V}$, $V_{GS}=0\text{ V}$	C_{oss}		2065		pF
Reverse transfer capacitance $f=1\text{MHz}$, $V_{DS}=50\text{ V}$, $V_{GS}=0\text{ V}$	C_{rss}		59		pF
Gate Resistance $f=1\text{MHz}$, $V_{DS}=0\text{ V}$, $V_{GS}=0\text{ V}$	R_g		1.4		Ω
Total Gate Charge $V_{DS}=50\text{V}$, $ID= 20\text{A}$, $V_{GS}= 10\text{V}$	Q_G		134		nC
Gate to Source Charge $V_{DS}= 50\text{V}$, $ID= 20\text{A}$, $V_{GS}= 10\text{V}$	Q_{GS}		36		nC
Gate to Drain Charge $V_{DS}= 50\text{V}$, $ID= 20\text{A}$, $V_{GS}= 10\text{V}$	Q_{GD}		27		nC
Turn-on delay time $V_{DS}=50\text{ V}$, $ID=20\text{A}$, $V_{GS}= 10\text{V}$, $R_{GEN}=3\Omega$	$t_{d (\text{ON})}$		21		ns
Rise time $V_{DS}=50\text{ V}$, $ID=20\text{A}$, $V_{GS}= 10\text{V}$, $R_{GEN}=3\Omega$	tr		28		ns
Turn-off delay time $V_{DS}=50\text{ V}$, $ID=20\text{A}$, $V_{GS}= 10\text{V}$, $R_{GEN}=3\Omega$	$t_{d (\text{OFF})}$		72		ns
Fall time $V_{DS}=50\text{ V}$, $ID=20\text{A}$, $V_{GS}= 10\text{V}$, $R_{GEN}=3\Omega$	tf		37		ns

Body Diode

ELECTRICAL CHARACTERISTICS (at $T_J = 25^\circ C$, unless otherwise specified)

Characteristic	Symbol	Min.	Typ.	Max.	Unit
Diode Forward Voltage $V_{GS} = 0V$, $I_S = 2.0A$ $T_j=25^\circ C$	V_{SD}		0.7	1.2	V
Diode Forward Current $T_j=25^\circ C$	I_S			351	A
Revers Recovery Time $IF=20A$, $dI/dt = 100A/us$ $\square T_j=25^\circ C$	T_{rr}		85		ns
Revers Recovery Charge $IF=20A$, $dI/dt = 100A/us$ $\square T_j=25^\circ C$	Q_{rr}		251		nC

Typical Electrical and Thermal Characteristics

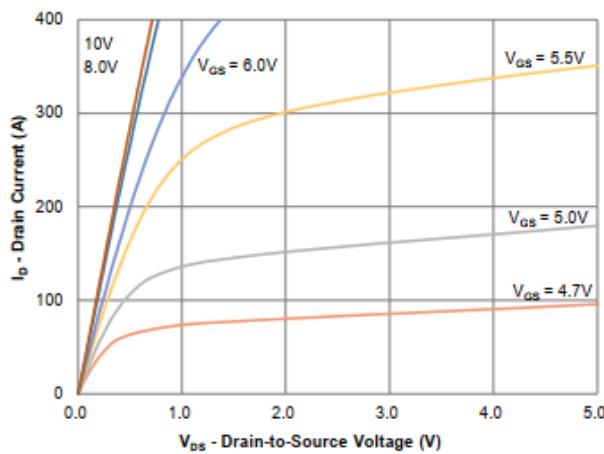
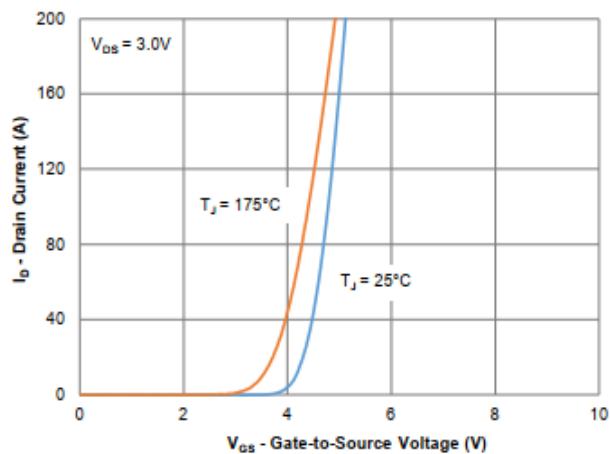
Figure 1. Typical output characteristics ($T_J=25^\circ\text{C}$)

Figure 2. Typical Transfer Characteristics

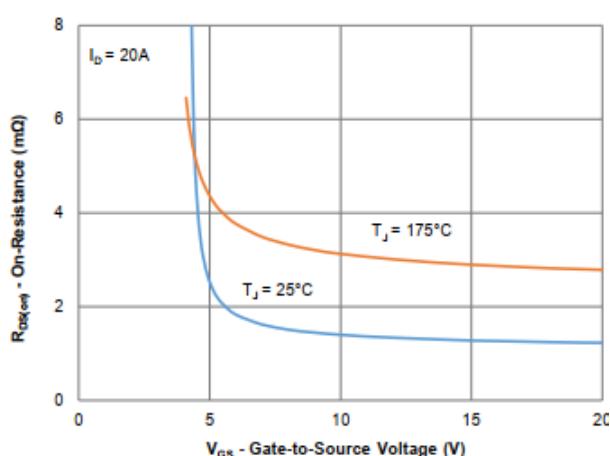


Figure 3. On-Resistance vs. Gate-Source Voltage

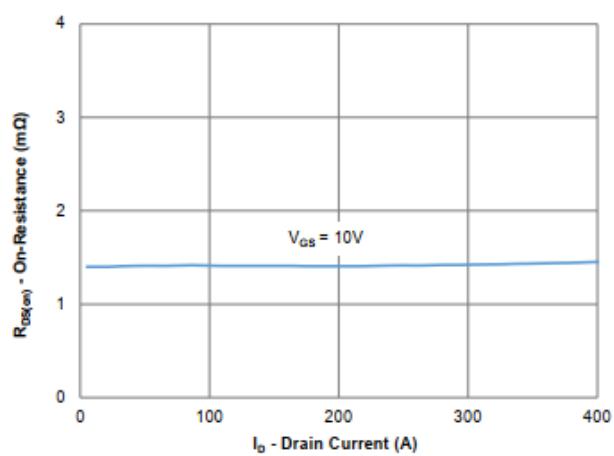


Figure 4. On-Resistance vs. Gate-Source Voltage

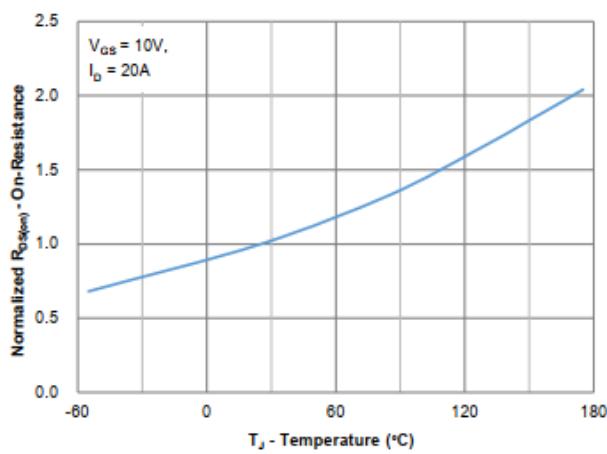


Figure 5. On-Resistance vs. Junction Temperature

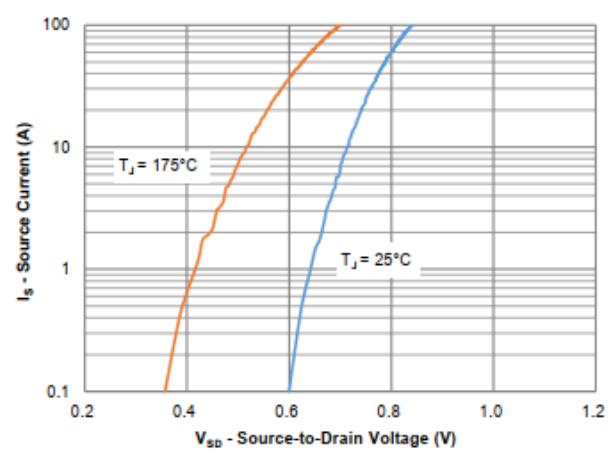


Figure 6. Source-Drain Diode Forward Voltage

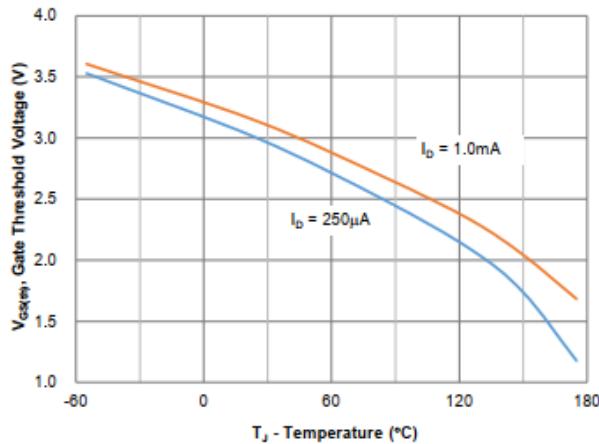


Figure 7. Gate Threshold Variation vs. Junction Temperature

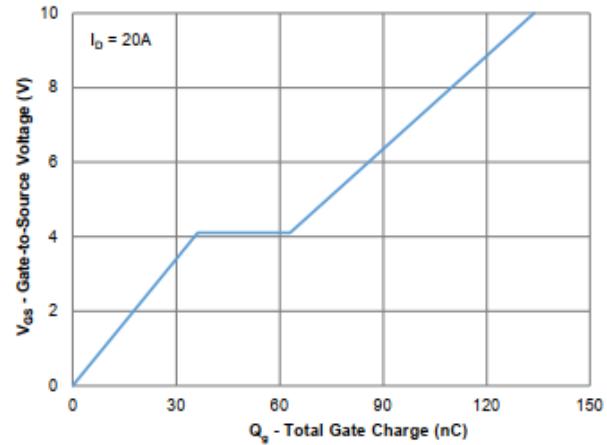


Figure 8. Gate Charge Characteristics

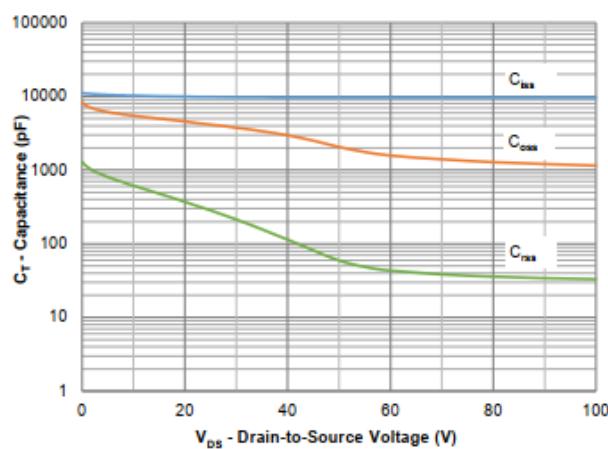


Figure 9. Capacitance Characteristics

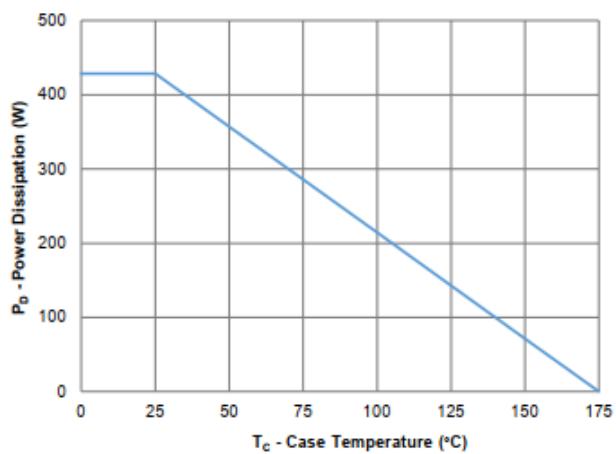


Figure 10. Power Derating

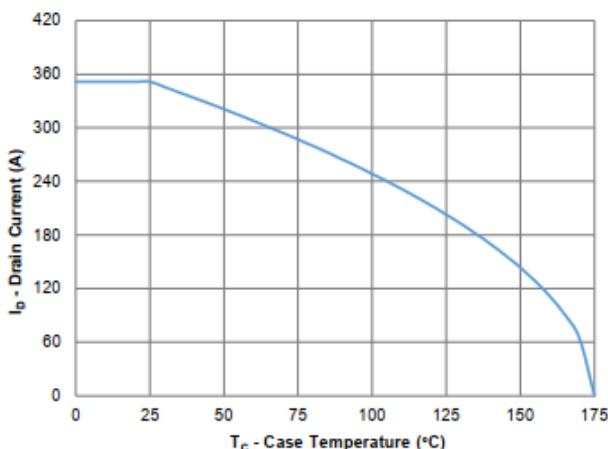


Figure 11. Current Derating

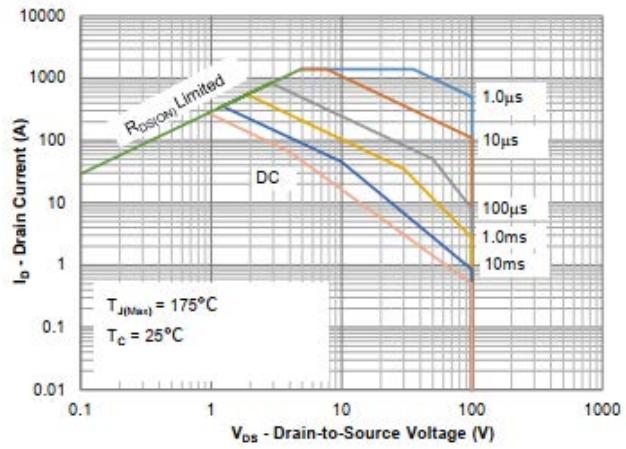


Figure 12. Safe Operating Area

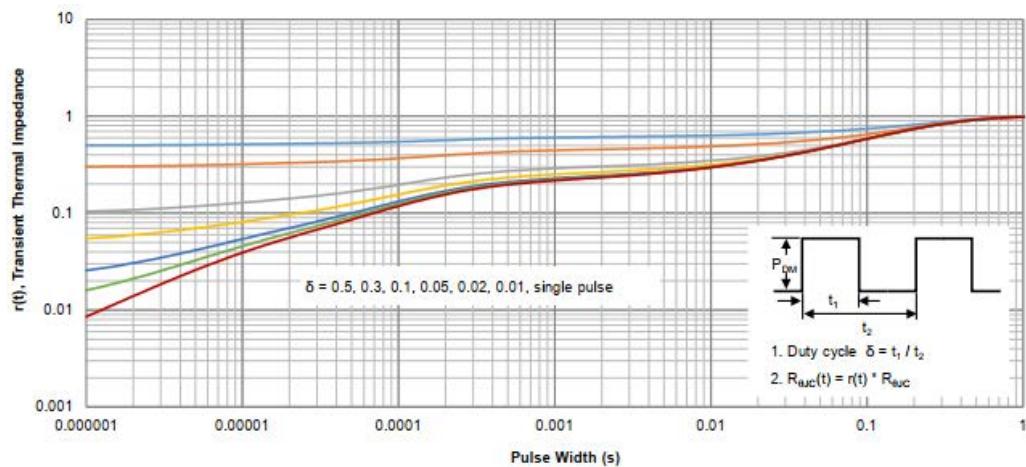
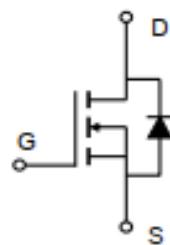
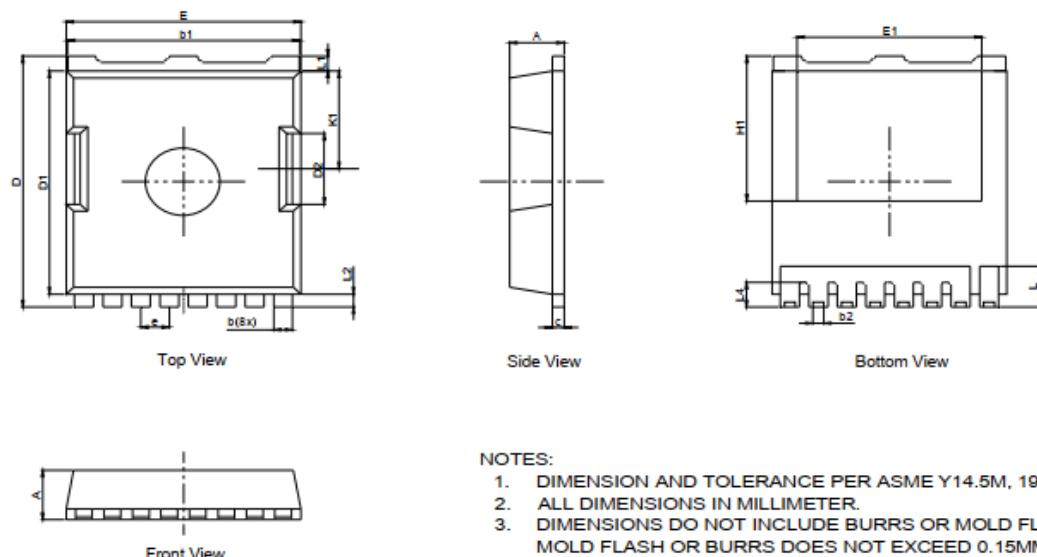


Figure 13. Max. Normalized Maximum Transient Thermal Impedance

- Circuit diagram



- TOLL Package outlines : Dimensions in (mm)



DIM.	MILLIMETER		
	MIN.	NOM.	MAX.
A	2.20	2.30	2.40
b	0.65	0.80	0.90
b1	9.65	9.80	9.95
c	0.40	0.50	0.60
D	11.48	11.68	11.95
D1	10.25	—	10.70
D2	2.85	—	3.40
E	9.70	9.90	10.10
E1	8.00	—	9.25
e	1.20(BSC)		
H1	6.70	7.00	7.30
K1	4.55		
L	1.35	—	2.10
L1	0.70		
L2	0.60		
L4	0.95	1.20	1.35

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